

<b>Notice of References Cited</b>	Application/Control No. 10/760,038	Applicant(s)/Patent Under Reexamination CHEN, TEI-FU	
	Examiner Matthew O. Savage	Art Unit 1724	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,348,155	02-2002	Conway et al.	210/668
	B	US-5,874,741	02-1999	Matschke, Arthur L.	250/435
	C	US-4,615,799	10-1986	Mortensen, Jorgen G.	210/177
	D	US-3,856,671	12-1974	Lee et al.	210/760
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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